



Advanced Remote Sensing Imaging for Environmental Sciences

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Deadline for manuscript
submissions:

closed (30 June 2024)

Message from the Guest Editors

Dear Colleagues,

Remote sensing imaging is an active source of spatial information which has been proven to be effective in measuring and monitoring the environment. Conversely, hyperspectral remote sensing imaging combines imaging technology with spectral detection technology, which is characterized by integrating image information of the sample with spectral information. However, the ability of existing methods to identify features is significantly affected by the high data dimensionality and massive information redundancy of hyperspectral remote sensing data. To solve the above problems, we must develop a variety of advanced hyperspectral remote sensing imaging analysis techniques for use in environmental monitoring systems.

This Special Issue encourages scholars and experts to submit works that systematically explore various advanced remote sensing imaging methods for application to environmental science to provide new ideas and references for exploring and addressing pressing environmental science issues. We welcome both original research and review articles.

Dr. Weiwei Cai
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Guest Editors





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Message from the Editor-in-Chief

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